



## PCIe® 4.0/3.0/2.0/1.0 Clock Generator with 2 HCSL Outputs

#### **Features**

- → PCIe® 4.0/3.0/2.0/1.0 compliant
- → LVDS compatible outputs
- → Supply voltage of 3.3V ±10%
- → 25MHz crystal or clock input frequency
- → HCSL outputs, 0.8V Current mode differential pair
- → Jitter 35ps cycle-to-cycle (typ)
- → RMS phase jitter 12kHz ~ 20MHz @ 100MHz 0.32ps (typ)
- → RMS phase jitter 12kHz ~ 20MHz @ 125MHz 0.3ps (typ)
- → Industrial temperature range
- → Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- → Halogen and Antimony Free. "Green" Device (Note 3)
- → For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/
- → Packaging (Pb-free and Green):
  - 16-pin TSSOP (L16)

# 125

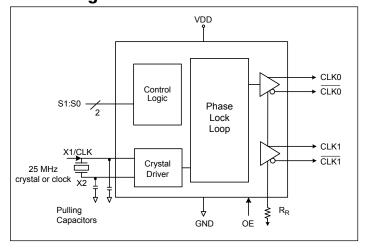
**Description** 

# PC or embedded systems. The PI6LC48H02 provides two differential (HCSL) or LVDS outputs. Using Diodes' patented Phase Locked Loop (PLL) techniques, the device takes a 25MHz crystal input and produces two pairs of differential outputs (HCSL) at 25MHz, 100MHz, 125MHz, 200MHz clock frequencies.

The PI6LC48H02 is a clock generator compliant to PCI Express<sup>®</sup>

4.0/3.0/2.0/1.0 and Ethernet requirements. The device is used for

# **Block Diagram**



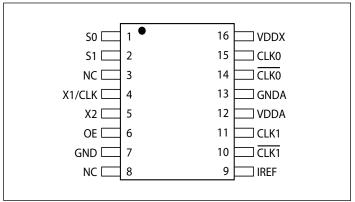
#### Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





# **Pin Configuration**



# **Pin Description**

Pin #	Pin Name	I/O Type	Description
1	S0	Input	Select pin 0 (Internal pull-up resistor). See Table 1.
2	S1	Input	Select pin 1 (Internal pull-up resistor). See Table 1.
3	NC	-	Do not connect
4	X1/CLK	Input	Crystal or clock input. Connect to a 25MHz crystal or single ended clock.
5	X2	Output	Crystal connection. Leave unconnected for clock input.
6	OE	Input	Output enable. Internal pull-up resistor.
7	GND	Power	Ground
8	NC	-	Do not connect
9	IREF	Output	Precision resistor attached to this pin is connected to the internal current reference.
10	CLK1	Output	HCSL compliment clock output
11	CLK1	Output	HCSL clock output
12	VDDA	Power	Connect to a +3.3V source.
13	GNDA	Power	Output and analog circuit ground.
14	CLK0	Output	HCSL compliment clock output
15	CLK0	Output	HCSL clock output
16	VDDX	Power	Connect to a +3.3V source.

## **Table 1: Output Select Table**

S1	S0	CLK(MHz)
0	0	25
0	1	100
1	0	125
1	1	200





# Application Information

## **Decoupling Capacitors**

Decoupling capacitors of  $0.01\mu F$  should be connected between each  $V_{DD}$  pin and the ground plane and placed as close to the  $V_{DD}$  pin as possible.

## Crystal

Use a 25MHz fundamental mode parallel resonant crystal with less than 300PPM of error across temperature.

## **Crystal Capacitors**

 $C_L$  = Crystals's load capacitance in pF

Crystal Capacitors (pF) =  $(C_L - 8) *2$ 

For example, for a crystal with 16pF load caps, the external effective crystal cap would be 16 pF. (16-8)\*2=16.

## Current Source (IREF) Reference Resistor - R<sub>R</sub>

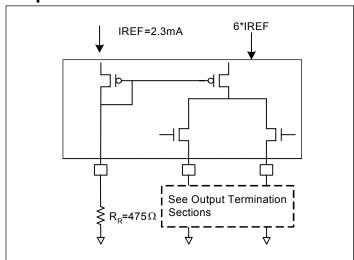
If board target trace impedance is  $50\Omega$ ,

then  $R_R = 475\Omega$  providing an IREF of 2.32 mA. The output current ( $I_{OH}$ ) is 6\*IREF.

#### **Output Termination**

The PCI Express differential clock outputs of the PI6LC48H02 are open source drivers and require an external series resistor and a resistor to ground. These resistor values and their allowable locations are shown in detail in the PCI Express Layout Guidelines section. The PI6LC48H02 can be configured for LVDS compatible voltage levels. See the LVDS Compatible Layout Guidelines section.

## **Output Structures**







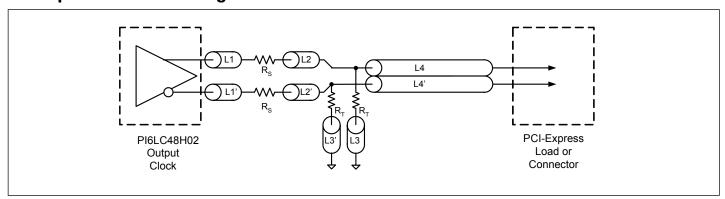
# **PCI Express Layout Guidelines**

Common Recommendations for Differential Routing	Dimension or Value	Unit
L1 length, route as non-coupled $50\Omega$ trace.	0.5 max	inch
L2 length, route as non-coupled $50\Omega$ trace.	0.2 max	inch
L3 length, route as non-coupled $50\Omega$ trace.	0.2 max	inch
$R_{S}$	33	Ω
$R_{\mathrm{T}}$	49.9	Ω

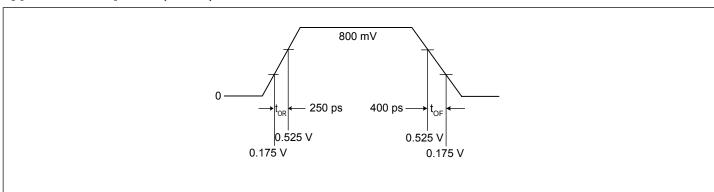
Differential Routing on a Single PCB	Dimension or Value	Unit	
L4 length, route as coupled microstrip $100\Omega$ differential trace.	2 min to 16 max	inch	
L4 length, route as coupled stripline $100\Omega$ differential trace.	1.8 min to 14.4 max	inch	

Differential Routing to a PCI Express connector	Dimension or Value	Unit
L4 length, route as coupled microstrip $100\Omega$ differential trace.	0.25 min to 14 max	inch
L4 length, route as coupled stripline $100\Omega$ differential trace.	0.225 min to 12.6 max	inch

# **PCI Express Device Routing**



# Typical PCI Express (HCSL) Waveform



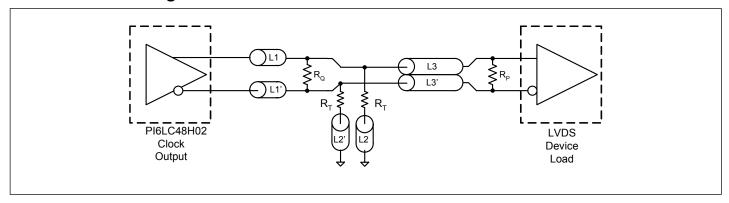




# **Application Information**

LVDS Recommendations for Differential Routing	Dimension or Value	Unit
L1 length, route as non-coupled $50\Omega$ trace.	0.5 max	inch
L2 length, route as non-coupled $50\Omega$ trace.	0.2 max	inch
RP	100	Ω
RQ	100	Ω
RT	150	Ω
L3 length, route as $100\Omega$ differential trace.		
L3 length, route as $100\Omega$ differential trace.		

# **LVDS Device Routing**







# **Maximum Ratings**

(Above which useful life may be impaired. For user guidelines, not tested.)

Supply Voltage to Ground Potential 4.6V
All Inputs and Outputs0.5V to VDD+0.5V
Storage Temperature65 to +150°C
Junction Temperature
Soldering Temperature
ESD Protection (HBM)

#### Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

# **Electrical Specifications**

## **Recommended Operation Conditions**

Parameter	Min.	Тур.	Max.	Unit
Ambient Operating Temperature	-40		+85	°C
Power Supply Voltage (measured in respect to GND)	+3.0		+3.6	V

## **DC Characteristics** ( $V_{DD} = 3.3V \pm 10\%$ , $T_A = -40$ °C to +85°C)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
$V_{DD}$	Supply Voltage		3.0	3.3	3.6	V	
V <sub>IH</sub>	Input High Voltage(1)	OE, S0, S1	2.0		V <sub>DD</sub> +0.3	V	
V <sub>IL</sub>	Input Low Voltage(1)	OE, S0, S1	GND -0.3		0.8	V	
$I_{IH}$	Input High Current	$Vin = V_{DD}$	-5		5	4	
$I_{IL}$	Input Low Current	Vin = 0	-20		20	μΑ	
$I_{DD}$	Operating Supply Cur-	$RL = 50\Omega$ , $CL = 2pF$			115	mA	
$I_{DDOE}$	rent	OE = LOW			65	mA	
C <sub>IN</sub>	Input Capacitance	@ 55MHz			7	pF	
C <sub>OUT</sub>	Output Capacitance	@ 55MHz			6	pF	
$L_{PIN}$	Pin Inductance				5	nН	
R <sub>OUT</sub>	Output Resistance	CLK Outputs	3.0			kΩ	

#### Notes:

1. Single edge is monotonic when transitioning through region.





# **HCSL Output AC Characteristics** ( $V_{DD} = 3.3V \pm 10\%$ , $T_A = -40$ °C to +85°C)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	In- dustry Max.	Unit
F <sub>IN</sub>	Input Frequency			25			MHz
F <sub>OUT</sub>	Output Frequency		25		200		MHz
$V_{OH}$	Output High Voltage (1,2)	100 MHz HCSL output @ $V_{DD}$ = 3.3V	660	800	900		mV
V <sub>OL</sub>	Output Low Voltage(1,2)		-150	0			mV
$V_{CPA}$	Crossing Point Voltage(1,2)	Absolute	250	350	550		mV
$V_{CN}$	Crossing Point Voltage <sup>(1,2,4)</sup>	Variation over all edges			140		mV
J <sub>CC</sub>	Jitter, Cycle-to-Cycle <sup>(1,3)</sup>			35	60		ps
	RMS Phase Jitter,	100MHz 25MHz Xtal input, 12kHz - 20MHz		0.32	0.5		ps
Phase	(Random)	125MHz 25MHz Xtal input, 12kHz - 20MHz		0.3	0.5		ps
		PCIe 2.0 Test Method @ 100MHz Output - Low BW		0.4	1.0	3.0	ps
JRMS2.0	PCIe 2.0 RMS Jitter	PCIe 2.0 Test Method @ 100MHz Output - High BW		1.9	2.5	3.1	ps
		PLL L-BW @ 2M & 5M 1st H3		1.42	1.9	3	ps
т	DCI- 2 0 DMC Ett-	PLL L-BW @ 2M & 4M 1st H3		2.05	2.5	3	ps
$J_{RMS3.0}$	PCIe 3.0 RMS Jitter	PLL H-BW @ 2M & 5M 1st H3		0.45	0.7	1	ps
		PLL H-BW @ 2M & 4M 1st H3		0.45	0.7	1	ps
$J_{\text{RMS4.0}}$	PCIe 4.0 RMS Jitter	PCIe Gen 4 (PLL BW of 2-4 or 2-5MHz, CDR =10MHz)		0.37	0.45	0.5	ps
$t_{OR}$	Rise Time <sup>(1,2)</sup>	From 0.175V to 0.525V	175		700		ps
t <sub>OF</sub>	Fall Time <sup>(1,2)</sup>	From 0.525V to 0.175V	175		700		ps
$T_{SKEW}$	Skew between outputs	At Crossing Point Voltage			50		ps
T <sub>DUTY-CYCLE</sub>	Duty Cycle <sup>(1,3)</sup>		45		55		%
$T_{OE}$	Output Enable Time <sup>(5)</sup>	All outputs			10		μs
$T_{OT}$	Output Disable Time <sup>(5)</sup>	All outputs			10		μs
$t_{STABLE}$	Stabilization Time	From Power-up V <sub>DD</sub> =3.3V		3.0			ms

#### Notes:

- 1.  $R_L = 50\Omega$  with  $C_L = 2 pF$
- 2. Single-ended waveform
- 3. Differential waveform
- 4. Measured at the crossing point
- 5. CLK pins are tri-stated when OE is LOW





## **Thermal Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$\theta_{\scriptscriptstyle JA}$	Thermal Resistance Junction to Ambient	Still air			90	°C/W
$\theta_{ ext{JC}}$	Thermal Resistance Junction to Case				24	°C/W

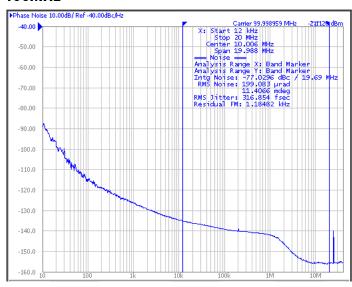
#### **Recommended Crystal Specification**

## Diodes recommends:

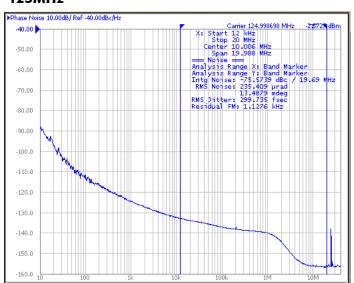
- a) GC2500003 XTAL 49S/SMD(4.0 mm), 25M, CL=18pF, +/-30ppm
- b) FY2500107, SMD 5x3.2(4P), 25M, CL=18pF, +/-30ppm
- c) FL2500038, SMD 3.2x2.5(4P), 25M, CL=18pF, +/-20ppm

## **Phase Noise Plot**

## 100MHz



## 125MHz



## **Part Marking**



Z: Die Rev YY: Year

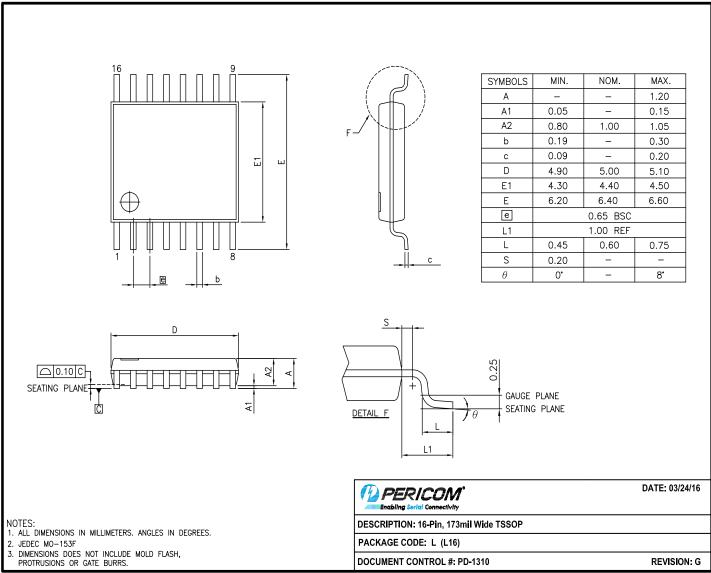
WW: Workweek

1st X: Assembly Code 2nd X: Fab Code





# Packaging Mechanical: 16-TSSOP (L)



16 0061

#### For latest package info.

 $please\ check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/packaging/packaging-mechanicals-and-thermal-characteristics/pack$ 

# **Ordering Information**

Ordering Code	Package Code	Package Description	<b>Operating Temperature</b>
PI6LC48H02LIEX	L	16-pin, 173mil Wide (TSSOP)	Industrial

#### Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. E = Pb-free and Green
- 5. X suffix = Tape/Reel





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